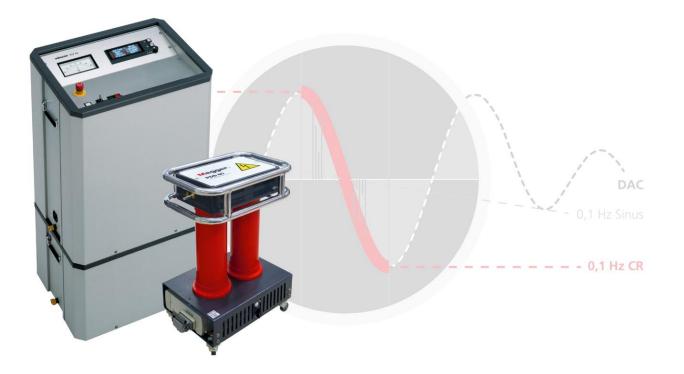
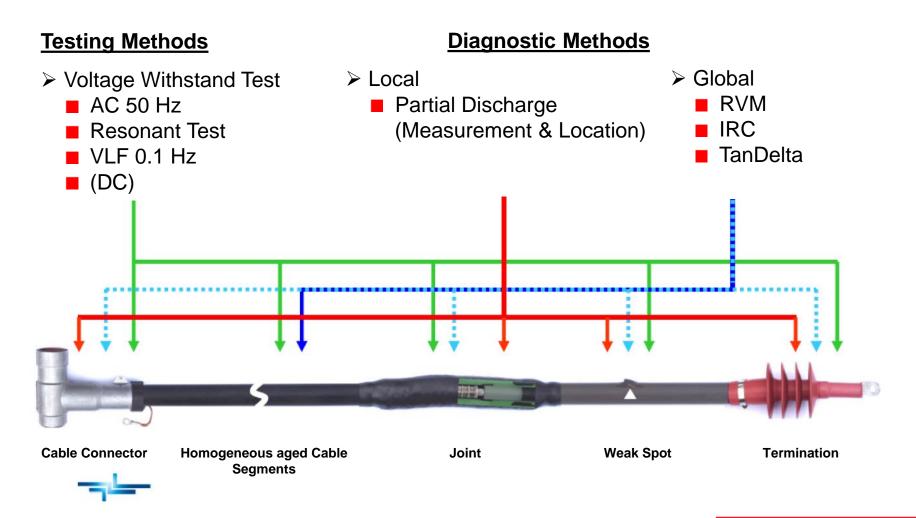
The Next Generation of Partial Discharge Diagnostic Systems



Philipp Legler

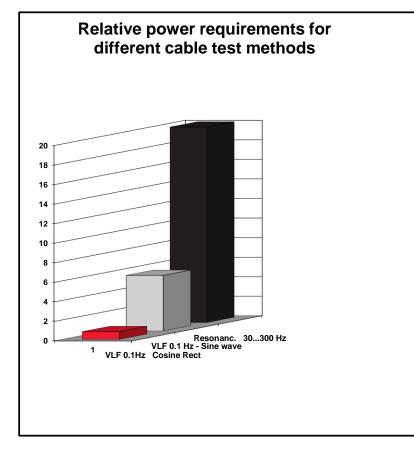


Testing & Diagnostic Opportunities

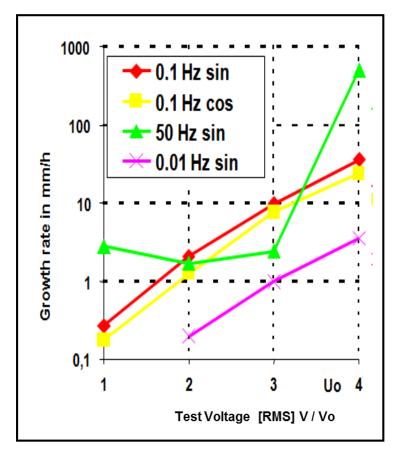




Commissioning Testing using VLF 0.1 Hz



Relative Power Ratings required for different test methods for the same test load



Electrical tree growth rate for different voltage wave shapes as a function of the applied test voltage (RMS)

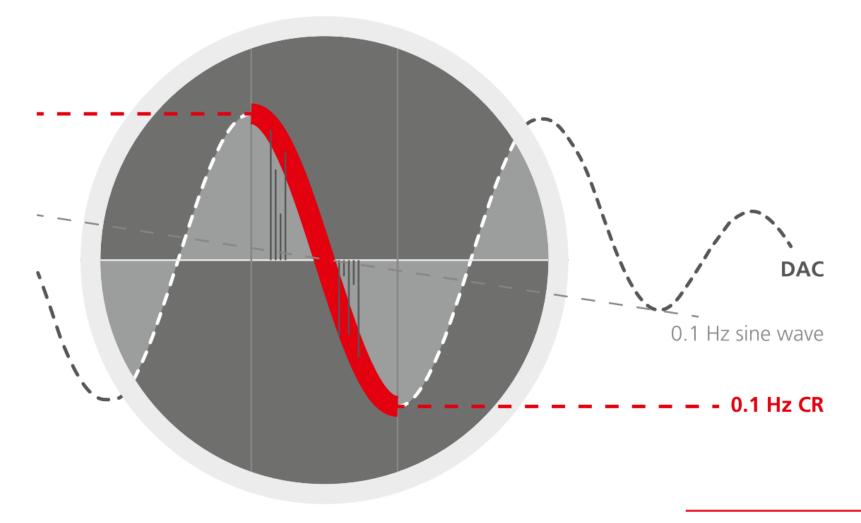
Influence of Frequency

- Test at lower Frequencies (e.g.: 0.01 Hz instead of 0.1 Hz) result in lower Growth Rate of Electrical Trees
 - Growth Rate: 10 times lower (roughly)
 - ➡ Testing Time: 10 times higher (should be !!!)
 - For Example: Commissioning Test at 3 U₀
 - ➡0.1 Hz 1 h
 - ➡0.01Hz 10 h



- Tree Growth Rate at 0.1 Hz comparable for Sinusoidal & CR
- Tree Growth Rate at 50 Hz lower then at 0.1Hz, especially when looking to Test Standard (50Hz ≥ 2 U₀ & 0.1Hz ≥ 3 U₀)
 - ➡ Testing with 0.1 Hz more effective

New TDS-NT - 50 Hz Slope Technology

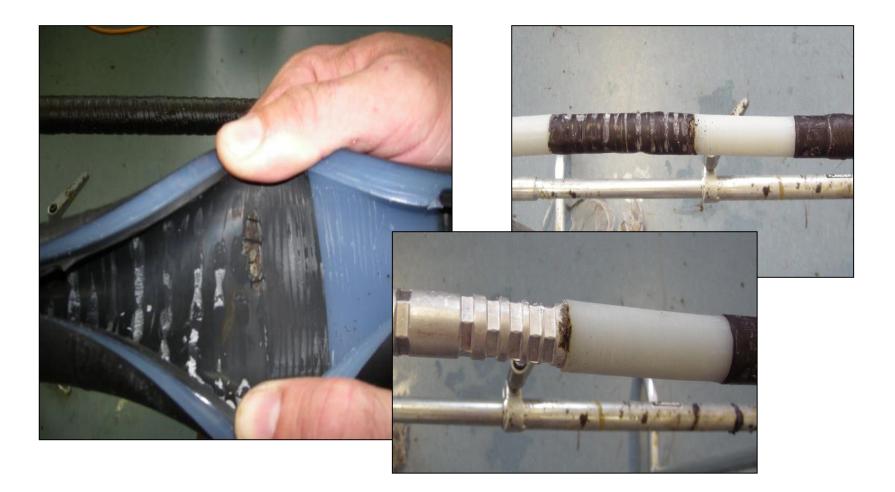


Withstand - & Diagnostic Testing

PD Diagnosis Withstand Testing Non destructive; Short Excitation Pass / fail Test; Provide sufficient Time; Characteristics comparable to Testing Stress; Additional PD Power Frequency; Localization Monitoring Ψī R C_{Testobject} **+U↓** [-U↑ 0 S **Very low Frequency** Damped AC Schematic / Test Set **Cosine Rectangular** (DAC) (VLF CR) +U +U voltage voltage time time B -U 30 - 400Hz 30 – 400Hz 5sec

Megger.

Assembly Fault detected by PD Testing



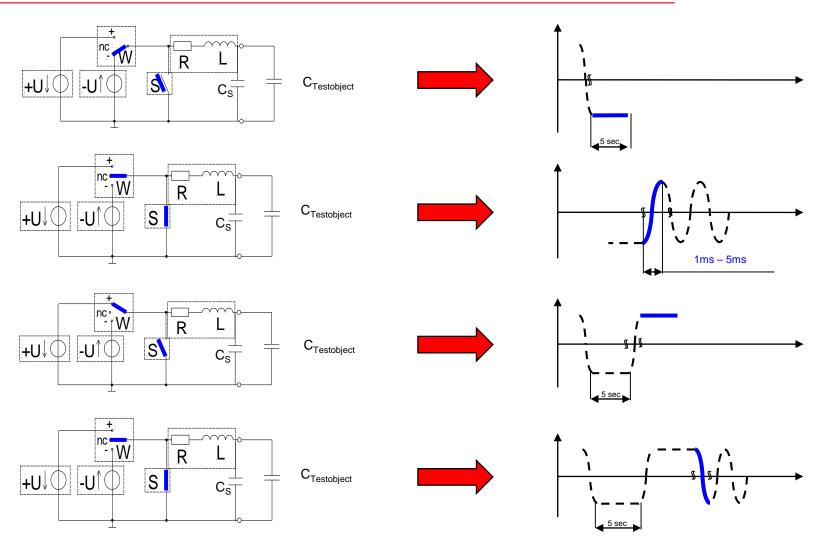
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Assembly Fault detected by PD Testing





Cosine Rectangular Voltage Generation



Comparability of relevant PD Parameters

Comparison to 50 Hz Power Frequency

	DAC	VLF CR Slope
PD Inception Voltage (PDIV)	\checkmark	\checkmark
PD Extinction Voltage (PDEV)	\checkmark	\checkmark
Voltage Gradient / Frequency	20-300Hz	20-300Hz
PD Level	\checkmark	\checkmark

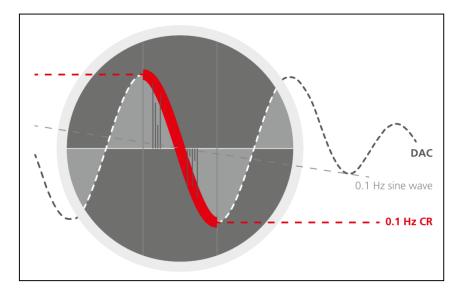
New TDS Series

50 Hz Slope Technology

- Both VLF CR & DAC Voltage Wave Shapes are having a Frequency comparable to the 50/60 Hz Power Frequency
 - ➡ Therefore Wave Shapes are *ideal for a PD Diagnosis*
 - In Dontrast to VLF 0.1 Hz Sinusoidal Voltages with a difference in Frequency of 500/600 Times

VLF CR

- PD measured only during
 Voltage Transition
- DAC
 - PD measured during oscillating Phase



New TDS Series

Functionalities of TDS Power Source

- Up to User to decide
- TDS together with PDS 60 for PD Diagnostics
- TDS ("only") for:
- High power VLF Withstand Testing (with Leakage Current Indication*)
- DC Testing
- Sheath Testing
- As Power Source for Sheath Fault Pin-pointing with optional ESG NT Step Voltage Probe





Functionalities of TDS Power Sources

Technical Data

Variant	TDS 40	TDS 60
Output voltage VLF DAC DC	3 40 kV _{RMS} 3 40 kV _{peak} 3 ±40 kV	3 60 kV _{RMS} 3 60 kV _{peak} 3 ±60 kV
Output current	7 mA	5 mA
Leakage current measurement	0 7 mA, resolution 10 μA	0 5 mA, resolution 10 μA
Frequency VLF DAC	0.1 Hz 50 to 500 Hz	
Testable cable capacitance VLF		
Basic version	2.4 μF / 40 kV _{RMS} @ 0.1 Hz	1 μF / 60 kV _{RMS} @ 0.1 Hz
Plus version	4.8 μF / 40 kV _{RMS} @ 0.1 Hz	2 μF / 60 kV _{RMS} @ 0.1 Hz
Testable cable capacitance DAC	5 μF / 40 kV _{peak} 10 μF max.	2 μF / 60 kV _{peak} 10 μF max.
Sheath test / fault pinpointing	Testing: 3 10 kV Pinpointing: 3 10 kV, pulse 1:3 / 1:5 / 1:9	
Safety devices	Breakdown detection, integrated discharge unit, earth loop monitoring	
Power supply	230 V, 50/60 Hz, 500 VA 120 V, 60 Hz, 500 VA	
Logging	Yes	
Temperature Operation Storage	-25 °C +55 °C -40 °C +70 °C	
Relative humidity	93% / 30 °C (non-condensing)	93% / 30 °C to 50 kV (non-condensing) 70% / 30 °C from 50 kV to 60 kV (non-condensing)
Protection class	IP 20	
Weight (depends on options fitted)	Approx. 55 kg + 48 kg	Approx. 85 kg + 48 kg
Dimensions W x H x D, divided in two devices	550 x 1100 x 420 mm	550 x 1100 x 420 mm

 Basic & plus
 Version are available

 Plus Version with higher testable
 Capacity

New TDS Series

Two Voltage Levels are available

TDS NT-40 Basic or Plus

- For powerful VLF Testing with accompanying PD Measurement up to 23..25 kV rated Cables with Test Voltage 3 U₀ (4.8 μF)
- For PD Diagnosis up to 36 kV rated Cables with 2 U₀ Test Voltage (DAC)

TDS NT-60 Basic or Plus

- For powerful VLF Testing with accompanying PD Measurement up to 36 kV rated Cables with Test Voltage 3 U_0 (2 μ F)
- For PD Diagnosis up to 45 kV rated Cables with 2 U₀ Test Voltage (DAC)

New TDS Series

- Functionalities of PDS PD Detector
- With Help from PDS 60 the TDS Power Source gets upgraded to multifunctional Diagnostic Test Set capable of:

PD Diagnosis up to 60 kV_{peak} using *DAC* PD Diagnosis up to 60 kV_{RMS} using *VLF CR VLF monitored Withstand Testing*

up to 60 kV_{RMS}



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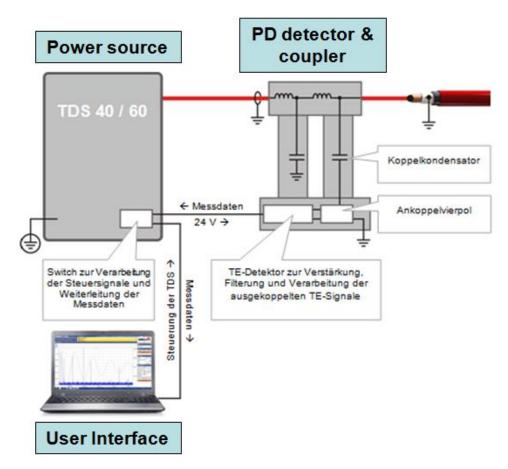
Functionalities of PDS PD Detector

Technical Data PDS 60

PD detector PDS 60	
Voltage Operation Type	max. 60 kV _{RMS} VLF CR or DAC
Capacity of HV coupling capacitor	25 nF
Sensitivity range	2 pC 100 nC
Resolution	± 0.1 pC
PD self-noise level	< 2 pC
PD impulse repetition rate	100 kHz
PD localization Measuring range Propogation velocity v/2 Sampling rate Bandwidth Precision Resolution	0 16.000 m / v/2= 80 m/µs 5 120 m/µs 125 MHz (8 ns) 3 / 25 MHz (switchable) 1% of the cable length ±0.1 pC / ±0.1 m
Filter	Analog and digital
Power supply	24 V via TDS test system
Temperature Operation Storage	-20 °C +55 °C -40 °C +70 °C
Relative humidity	93 % / 30 °C (non-condensing)
Weight HV filter/ coupler PD detector	25 kg 6 kg
Dimensions (W x D x H)	40 x 78 x 54 cm
PD calibrator (IEC 60270-compliant) Measuring range Power supply	200 pC 20 nC 9 V block battery
Software	EasyGo principle, integrated cable database, fully automatic evaluation

TDS NT Unit

Connection Diagram

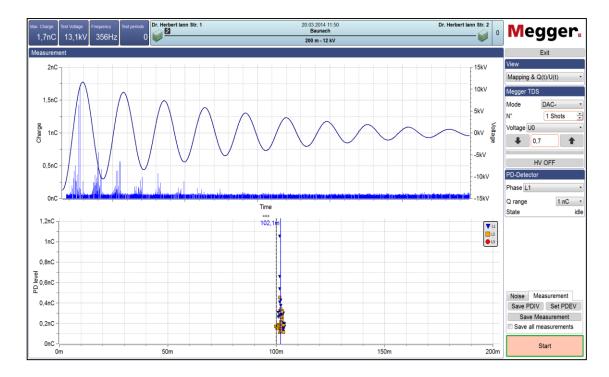




The Operating Software

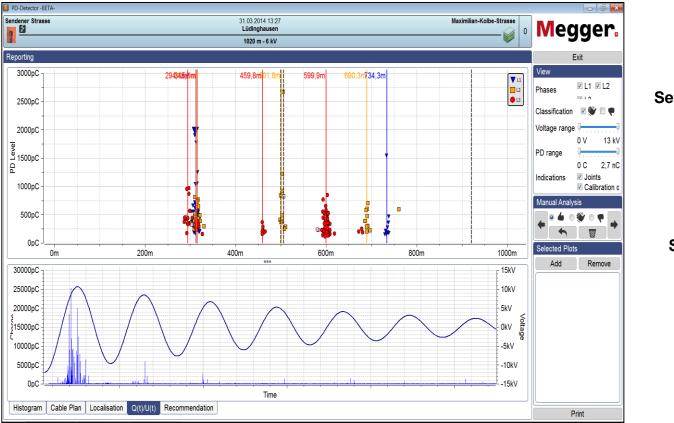
"Live" PD Mapping

PD Evaluation Algorithm enables a reliable automatic Detection & precise Location of Partial Discharges (PD Mapping) whilst Measurement is taking place



The Operating Software

Evaluation & Reporting



Settings for display of Results

Settings for manual Analysis

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Conclusion & Discussion

- Combined Voltage Generation System (DAC & VLF CR) allows Diagnosis & Withstand Testing in one System
- VLF CR Voltage Wave Shape is demonstrated as excellent Excitation Voltage for PD Testing
- VLF CR allows PD Monitored Withstand Testing on *longer Cables* or 3 *Phases in parallel* respectively by still using the most effective 0.1 Hz Test Frequency
- PD Parameter comparable to Power Frequency
- Localisation Map of PD Defects directly while Measurement
- Data Management due to innovative Database Concept
- Smart Reporting Functionality
- PD Pattern to be comparable at tested PD Defects
 Next Presentation



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Question Time





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Thank you for your attention!

Let's have a break ?





